

Centre Testing International (Shenzhen) Corporation

**Test Lab  
Attestation Letter**

**Date of Test:**

May 26, 2016 to Jun. 15, 2016

**Applicant Name:**

Sen.se

**FCC ID:**

2ABGNPEA001

**Test Items:**

Conducted Peak Output Power, 6dB Occupied Bandwidth, Power Spectral Density, Band-edge for RF Conducted Emissions, RF Conducted Spurious Emissions, Radiated Spurious Emissions, Restricted bands around fundamental frequency (Radiated Emission)

**Name of Engineer  
Performing Test:**

Kevin lan

**Statement of Compliance:**

Centre Testing International (Shenzhen) Corporation declares that this Unit has been tested in accordance with the test method identified in this test report and that we observed it being tested. It also declares that the Unit complies with the relevant limits. All instrumentation and accessories used to test this unit for compliance to the indicated test method are calibrated regularly in accordance with ISO 17025:2005 requirements by laboratories accredited by A2LA, NVLAP, or ACLAS for the measurement parameters.

**The measurements were made  
at:**

Centre Testing International (Shenzhen) Corporation  
Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong,  
China518101

**Test Lab Witness-**

**Signature of Test Lab Witness:**

*Sheek Luo*

**Full Name, Typed:**

Sheek Luo

**Title of Witness:**

Lab supervisor

**Email Address:**

sheek.luo@cti-cert.com

**Phone No.:**

0755 3368 2591

